

<b>Notice of References Cited</b>	Application/Control No. 10/749,554		Applicant(s)/Patent Under Reexamination LIN ET AL.	
	Examiner Julio R. Perez		Art Unit 2617	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
*	B	US-2004/0170149 A1	09-2004	Lee, Yung-Ting	370/338
*	C	US-2004/0038685 A1	02-2004	Nakabayashi, Sumie	455/452.2
*	D	US-7,006,472 B1	02-2006	Immonen et al.	370/332
*	E	US-2006/0009187 A1	01-2006	Sheynman et al.	455/318
*	F	US-7,162,236 B2	01-2007	Dorenbosch et al.	455/432.1
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.